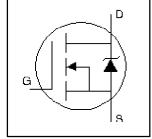
International IOR Rectifier HEXFET[®] Power MOSFET

- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- For Automatic Insertion
- End Stackable
- Fast Switching
- Ease of paralleling
- Simple Drive Requirements



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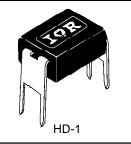
 $R_{DS(on)} = 2.0\Omega$ $I_{\rm D} = 0.45 {\rm A}$

 $V_{DSS} = 250V$



Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low onresistance and cost-effectiveness.

The 4-pin DIP package is a low-cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1 inch pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 watt.



Absolute Maximum Ratings

	U			
	Parameter	Max.	Units	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10 V	0.45		
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V _{GS} @ 10 V	0.29	A	
I _{DM}	Pulsed Drain Current ①	3.6		
$P_D @ T_C = 25^{\circ}C$	Power Dissipation	1.0	W	
	Linear Derating Factor	0.0083	W/°C	
V _{GS}	Gate-to-Source Voltage	±20	V	
E _{AS}	Single Pulse Avalanche Energy ②	57	mJ	
I _{AR}	Avalanche Current ①	0.45	A	
E _{AR}	Repetitive Avalanche Energy ①	0.10	mJ	
dv/dt	Peak Diode Recovery dv/dt 3	4.8	V/ns	
TJ	Operating Junction and	-55 to + 150		
T _{STG}	Storage Temperature Range		°C	
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)		

Thermal Resistance

	Parameter	Min.	Тур.	Max.	Units
$R_{\theta JA}$	Junction-to-Ambient	_	_	120	°C/W

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	250	—	—	V	$V_{GS} = 0V, ID = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.39	—	V/°C	Reference to 25° C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance	—	—	2.0	Ω	V _{GS} = 10.0V, I _D = 0.27A ④
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_D = 250 \mu A$
g fs	Forward Transconductance	0.90		_	S	V _{DS} = 50V, I _D = 1.6A
I _{DSS}	Drain-to-Source Leakage Current			25		$V_{DS} = 250V, V_{GS} = 0V$
		_	—	250	μA	$V_{DS} = 200V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage	_	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100	ПА	V _{GS} = -20V
Qg	Total Gate Charge	—	—	8.2		I _D = 2.7A
Q _{gs}	Gate-to-Source Charge	—	—	1.8	nC	V _{DS} = 200V
Q _{gd}	Gate-to-Drain ("Miller") Charge	—	—	4.5		V_{GS} = 10V, See Fig. 6 and 13 ④
t _{d(on)}	Turn-On Delay Time		7.0	_		V _{DD} = 125V
tr	Rise Time		7.6	_	ns	I _D = 2.7A
t _{d(off)}	Turn-Off Delay Time		16	_		$R_{G} = 24\Omega$
t _f	Fall Time		7.0	_		$R_D = 45\Omega$, See Fig. 10 ④
L _D	Internal Drain Inductance		4.0	_	nH	Between lead, p
LS	Internal Source Inductance	—	6.0	—		6mm (0.25in.)
						from package
						and center of
						die contact
Ciss	Input Capacitance		140	_		$V_{GS} = 0V$
Coss	Output Capacitance	—	42	_	pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance	—	9.6	—		f = 1.0MHz, See Fig. 5

Source-Drain Ratings and Characteristics

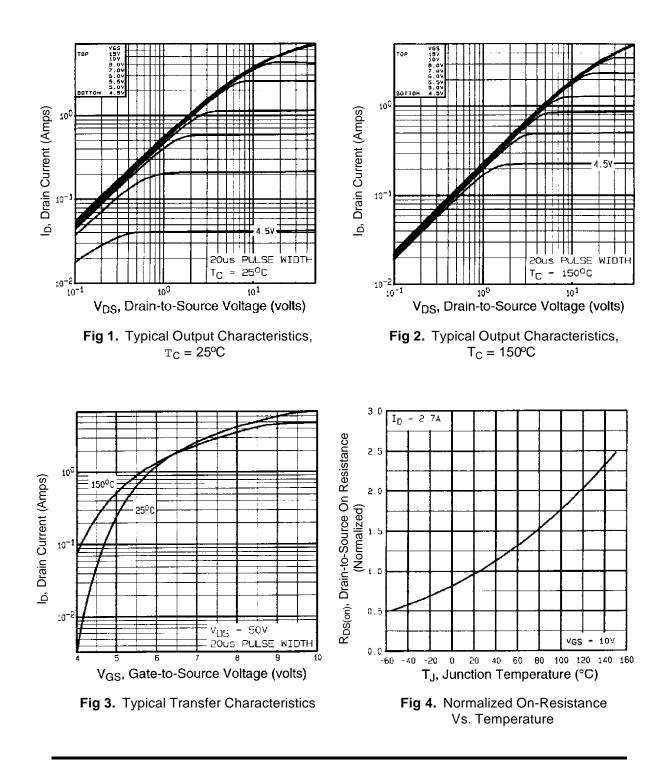
	Parameter	Min.	Тур.	Max.	Units	Conditions								
Is	Continuous Source Current			- 0.45		MOSFET symbol								
	(Body Diode)	_	_		А	showing the								
I _{SM}	Pulsed Source Current												A	integral reverse
	(Body Diode) ①	_		3.6		p-n junction diode.								
V _{SD}	Diode Forward Voltage	_	_	2.0	V	$T_J = 25^{\circ}C, I_S = 0.45A, V_{GS} = 0V$ (4)								
t _{rr}	Reverse Recovery Time	_	190	390	ns	$T_J = 25^{\circ}C, I_F = 2.7A$								
Q _{rr}	Reverse RecoveryCharge	_	0.64	1.3	μC	di/dt = 100A/µs ④								
t _{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{S}+L_{D}$)												

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- $\$ I_{SD} \leq 2.7A, di/dt \leq 65A/µs, V_{DD} \leq V_{(BR)DSS}, T_{J} \leq 150°C
- 0 V_{DD} = 50V, starting T_J = 25°C, L = 28mH R_G = 25 Ω , I_{AS} = 1.8A. (See Figure 12)
- ④ Pulse width $\leq 300 \mu s;$ duty cycle \leq 2%.

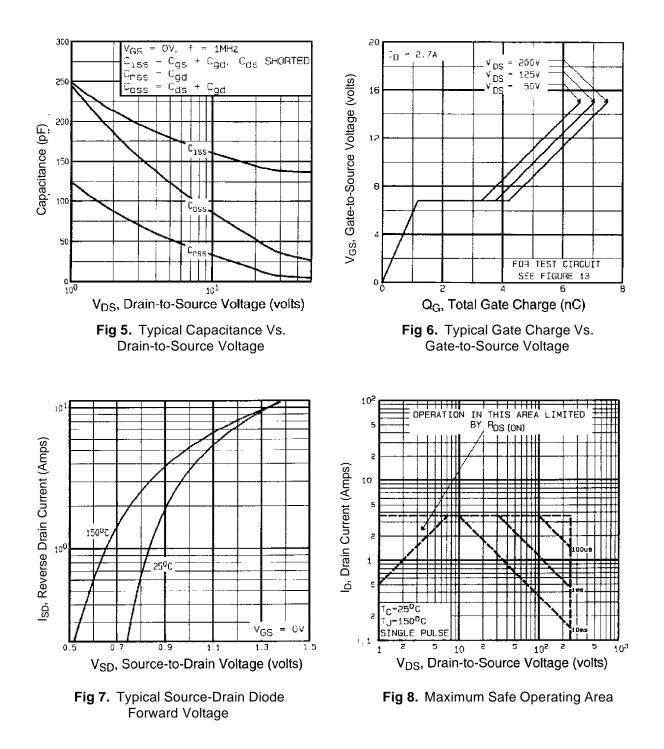
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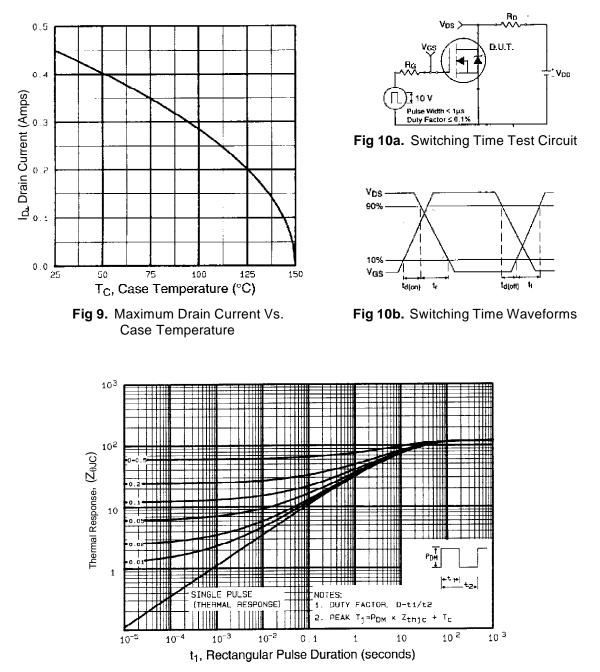


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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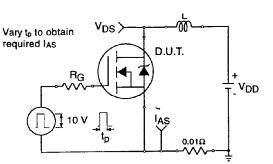
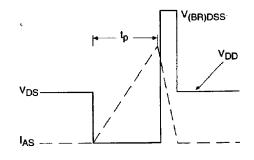
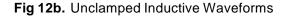


Fig 12a. Unclamped Inductive Test Circuit





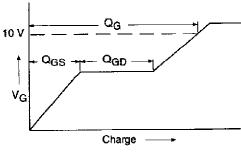
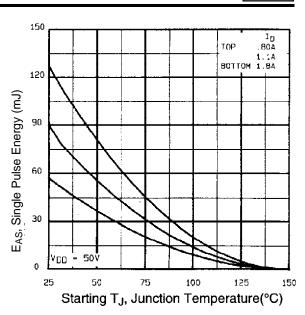
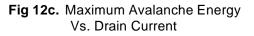
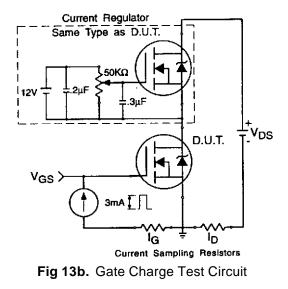


Fig 13a. Basic Gate Charge Waveform



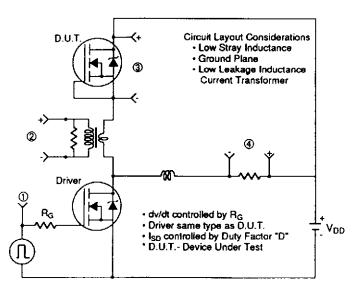




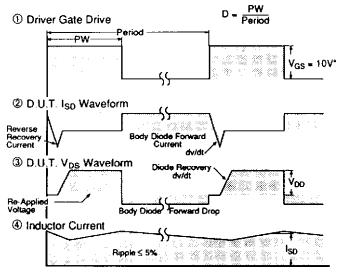
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dv/dt Test Circuit

Fig 14. For N-Channel HEXFETs



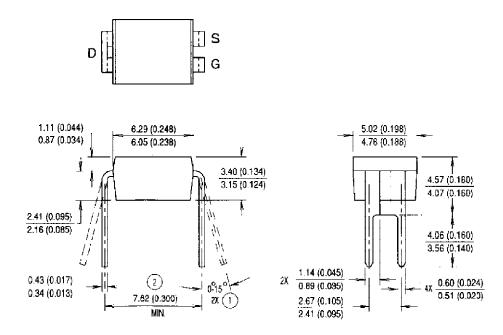
Peak Diode Recovery Test Circuit



* V_{GS} = 5V for Logic Level Devices

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Package Outline





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 EUROPEAN HEADQUARTERS:
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 IR CANADA:
 7321 Victoria Park Ave., Suite 201, Markham, Ontario L3R 3L1, Tel: (905) 475 1897
 IR GERMANY:

 Saalburgstrasse
 157, 61350 Bad Homburg Tel: 6172 37066
 IR ITALY:
 Via Liguria 49, 10071 Borgaro, Torino Tel: (39)

 1145 10111
 IR FAR EAST:
 K&H Bldg., 2F, 3-30-4 Nishi-Ikeburo 3-Chome, Toshima-Ki, Tokyo 171 Tel: (03)3983 0641

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 315 Outram Road, #10-02 Tan Boon Liat Building, 0316 Tel: 65 221 8371

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